Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/080,685	HAZE ET AL.	
Examiner	Art Unit	
Jungwon Chang	2154	

SEARCHED			
Class	Subclass	Date	Examiner
709	208	7/6/2007	JWC
709	225	7/6/2007	JWC
358	468	7/6/2007	JWC
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
709	208	7/6/2007	JMC
709	225	7/6/2007	JWC
358	468	7/6/2007	JWC
710/29, 200		7/6/2007	JWC

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East Google ACM; IEEE Search report attached	7/6/2007	JWC
Inventor name searched	7/6/2007	JWC